

Notice of References Cited		Application/Control No.	Applicant(s)/Patent Under Reexamination YUAN ET AL.	
		Examiner M. Lee	Art Unit 2622	Page 1 of 1

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*	Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A US-6,489,934	12-2002	Klausner, Judah	345/1.1
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C	US-			
D	US-			
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H	US-			
I	US-			
J	US-			
K	US-			
L	US-			
M	US-			

FOREIGN PATENT DOCUMENTS

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N					
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NON-PATENT DOCUMENTS

*	Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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